STF12N50M2

Datasheet - preliminary data



N-channel 500 V, 0.325 Ω typ.,10 A MDmesh II Plus[™] low Q_g Power MOSFET in a TO-220FP package

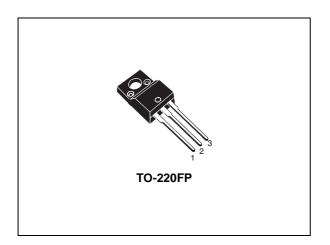
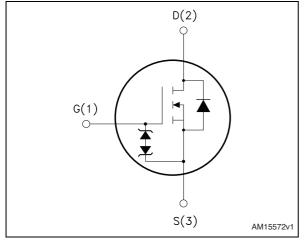


Figure 1. Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max	I _D
STF12N50M2	500 V	0.38 Ω	10 A

- Extremely low gate charge
- Lower R_{DS(on)} x area vs previous generation
- Low gate input resistance
- 100% avalanche tested
- Zener-protected

Applications

Switching applications

Description

This device is an N-channel Power MOSFET developed using a new generation of MDmeshTM technology: MDmesh II PlusTM low Q_g . This revolutionary Power MOSFET associates a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.

Table 1. Device summary

Order code	Marking	Package	Packaging
STF12N50M2	12N50M2	TO-220FP	Tube

This is preliminary information on a new product now in development or undergoing evaluation. Details are subject to change without notice.

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1

Electrical ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	± 25	V
۱ _D	Drain current (continuous) at $T_C = 25 \ ^{\circ}C$	10 ⁽¹⁾	А
۱ _D	Drain current (continuous) at $T_C = 100 \ ^{\circ}C$	7 ⁽¹⁾	А
I _{DM} ⁽²⁾	Drain current (pulsed)	40	А
P _{TOT}	Total dissipation at $T_C = 25 \ ^{\circ}C$	85	W
dv/dt ⁽³⁾	Peak diode recovery voltage slope	15	V/ns
dv/dt ⁽⁴⁾	MOSFET dv/dt ruggedness	50	V/ns
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; T_C =25 °C)	2500	v
T _{stg}	Storage temperature	- 55 to 150	.0°
Τ _j	Max. operating junction temperature	- 55 10 150	

Table 2. Absolute maximum ratings

1. Limited by maximum junction temperature

2. Pulse width limited by safe operating area.

3. I_{SD} \leq 10 A, di/dt \leq 400 A/ $\!\mu s;$ V_{DS peak} < V_{(BR)DSS}, V_DD=400 V.

 $4. \quad V_{DS} \leq 400 \ V$

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	5	°C/W
R _{thj-amb}	Thermal resistance junction-amb max	62.5	°C/W

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T _{jmax})	3.5	А
E _{AS}	Single pulse avalanche energy (starting $T_j=25$ °C, $I_D=I_{AR}$; $V_{DD}=50$)	204	mJ



2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0, I_{D} = 1 \text{ mA}$	500			۷
Zero gate voltage drain current	$V_{GS} = 0, V_{DS} = 500 V$			1	μA	
	V _{GS} = 0, V _{DS} = 500 V, T _C =125 °C			100	μA	
I _{GSS}	Gate-body leakage current	$V_{DS} = 0, V_{GS} = \pm 25 V$			±10	μA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu$ A	2	3	4	V
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 10 V, I _D = 5 A		0.325	0.38	Ω

Table	5.	On	/off	states
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Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
C _{iss}	Input capacitance		-	560	-	pF	
C _{oss}	Output capacitance	V _{GS} = 0, V _{DS} = 100 V,	-	33	-	pF	
C _{rss}	Reverse transfer capacitance	f = 1 MHz	-	1	-	pF	
C _{oss eq.} ⁽¹⁾	Equivalent output capacitance	$V_{GS} = 0, V_{DS} = 0 \text{ to } 400 \text{ V}$	-	125	-	pF	
R _G	Intrinsic gate resistance	f = 1 MHz, I _D =0	-	6.8	-	Ω	
Qg	Total gate charge		-	15	-	nC	
Q _{gs}	Gate-source charge	$V_{DD} = 400 \text{ V}, I_D = 10 \text{ A},$ $V_{GS} = 10 \text{ V} (\text{see Figure 15})$	-	3	-	nC	
Q _{gd}	Gate-drain charge		-	8.3	-	nC	

1. $C_{oss\;eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit			
t _{d(on)}	Turn-on delay time	$V_{DD} = 250 \text{ V}, \text{ I}_{D} = 5 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 14</i> and <i>19</i>)	-	13.5	-	ns			
t _r	Rise time		-	10.5	-	ns			
t _{d(off)}	Turn-off delay time		-	8	-	ns			
t _f	Fall time		-	34.5	-	ns			

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		10	А
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		40	А
$V_{SD}^{(2)}$	Forward on voltage	V _{GS} = 0, I _{SD} = 10 A	-		1.6	V
t _{rr}	Reverse recovery time		-	276		ns
Q _{rr}	Reverse recovery charge	I _{SD} = 10 A, di/dt = 100 A/μs V _{DD} = 60 V (see <i>Figure 16</i>)	-	2.4		μC
I _{RRM}	Reverse recovery current	$v_{DD} = 60 v (see Figure 10)$	-	17.5		А
t _{rr}	Reverse recovery time	I _{SD} = 10 A, di/dt = 100 A/µs	-	376		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V, T _j =150 °C	-	3.4		μC
I _{RRM}	Reverse recovery current	(see Figure 16)	-	18.3		Α

1. Pulse width limited by safe operating area

2. Pulsed: pulse duration = $300 \,\mu$ s, duty cycle 1.5%



2.1 Electrical characteristics (curves)

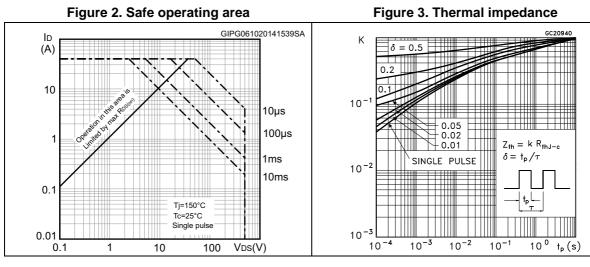
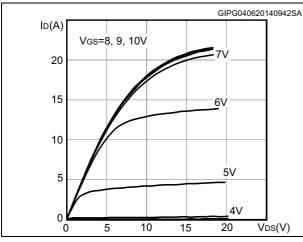


Figure 4. Output characteristics





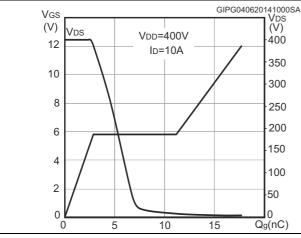
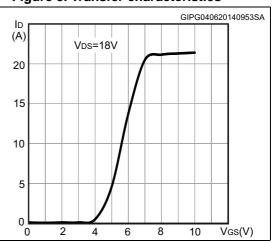
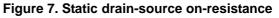
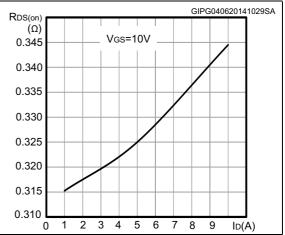


Figure 5. Transfer characteristics

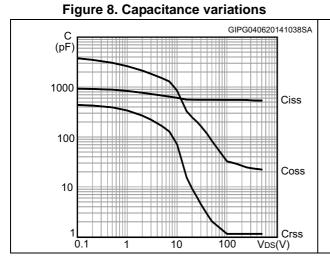


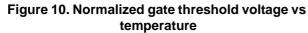




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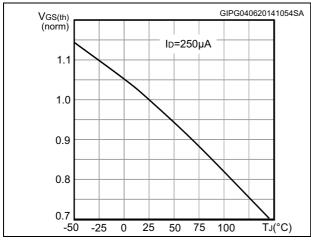
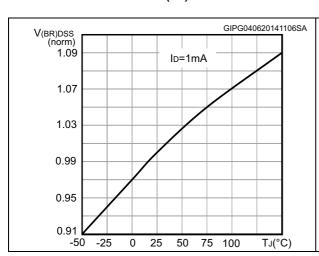
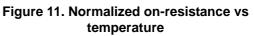


Figure 12. Normalized V_{(BR)DSS} vs temperature



Electrical characteristics

Figure 9. Output capacitance stored energy



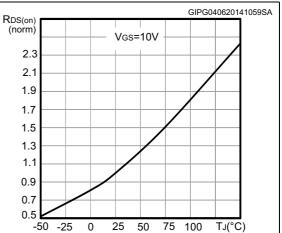
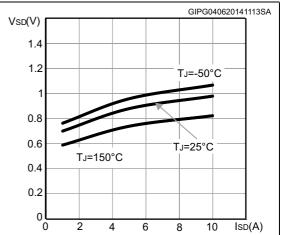


Figure 13. Source-drain diode forward characteristics





3 Test circuits

Figure 14. Switching times test circuit for resistive load

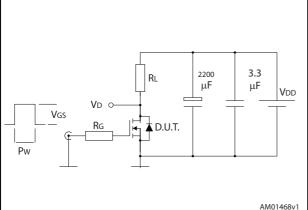


Figure 16. Test circuit for inductive load switching and diode recovery times

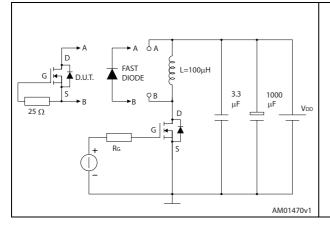


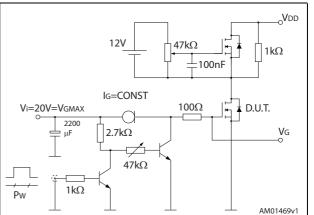
Figure 18. Unclamped inductive waveform

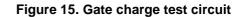
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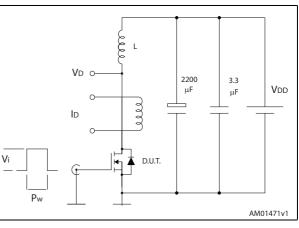
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V(BR)DSS









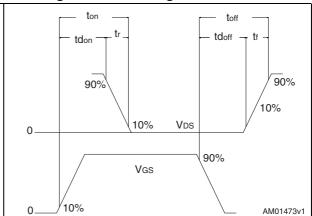


Figure 19. Switching time waveform



Vdd

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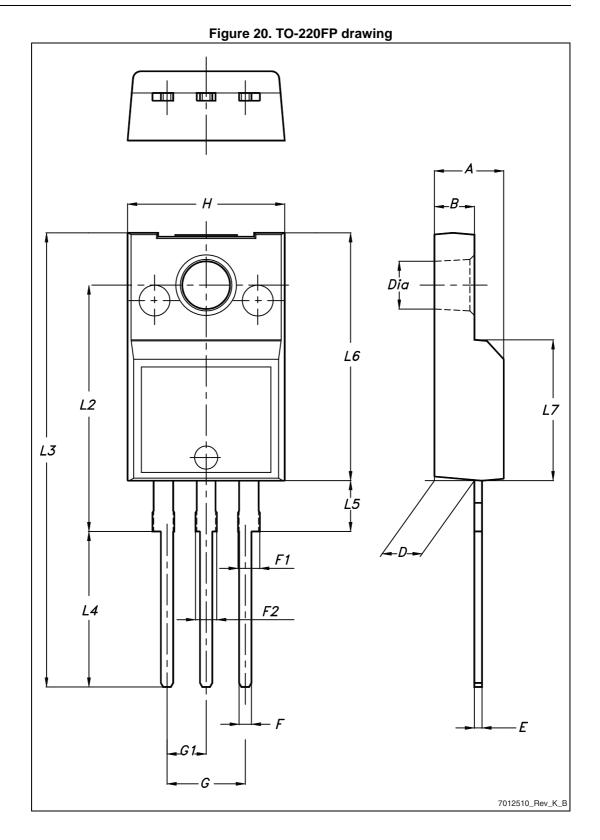


Vdd

4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.







Dim. —	mm			
	Min.	Тур.	Max.	
A	4.4		4.6	
В	2.5		2.7	
D	2.5		2.75	
E	0.45		0.7	
F	0.75		1	
F1	1.15		1.70	
F2	1.15		1.70	
G	4.95		5.2	
G1	2.4		2.7	
Н	10		10.4	
L2		16		
L3	28.6		30.6	
L4	9.8		10.6	
L5	2.9		3.6	
L6	15.9		16.4	
L7	9		9.3	
Ø	3		3.2	

Table 9. TO-220FP mechanical data



5 **Revision history**

Table 10. Document revision history				
Date	Revision	Changes		
18-Jun-2014	1	First release.		



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